# Main Switch Power MOSFET and Single Charging BJT

# -12 V, -6.2 A, Single P–Channel FET with Single PNP low $V_{ce(sat)}$ Transistor, 3x3 mm WDFN Package

This device integrates one high performance power MOSFET and one low  $V_{ce(sat)}$  transistor, greatly reducing the layout space and optimizing charging performance in battery–powered portable electronics.

### **Features**

- High Performance Power MOSFET
- Single Low V<sub>ce(sat)</sub> Transistor as Charging Power Mux
- 3.0x3.0x0.8 mm WDFN Package
- Independent Pin-out Provides Circuit Flexibility
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

# **Applications**

- Main Switch and Battery Charging Mux for Portable Electronics
- Optimized for Commercial PMUs from Top Suppliers (See Figure 2)

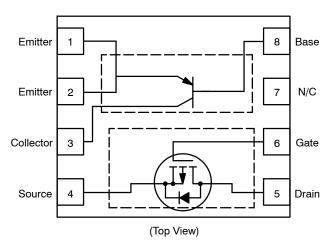


Figure 1. Simple Schematic



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# **MOSFET**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
10.1/	32 mΩ @ -4.5 V	604
-12 V	44 mΩ @ -2.5 V	−6.2 A

# Low V<sub>ce(sat)</sub> PNP (Wall/USB)

V <sub>CEO</sub> MAX	V <sub>EBO</sub> MAX	I <sub>C</sub> MAX	
–20 V	-7.0 V	-2.0 A	



# MARKING DIAGRAM

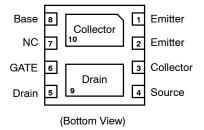
# WDFN8 CASE 506BC



5531 = Device Code
A = Assembly Location
Y = Year
WW = Work Week
= Pb-Free Package

(Note: Microdot may be in either location)

# **PIN ASSIGNMENT**



# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NUS5531MTR2G	WDFN8 (Pb-Free)	3000/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# P-Channel Power MOSFET Maximum Ratings (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units		
Drain-to-Source Voltage			$V_{DSS}$	-12	V
Gate-to-Source Voltage			$V_{GS}$	±8.0	V
Continuous Drain Current (Note 1)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-5.47	Α
		T <sub>A</sub> = 85°C		-4.0	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-6.2	
Power Dissipation (Note 1)	Steady State	T 0500	$P_{D}$	1.46	W
	t ≤ 10 s	$T_A = 25^{\circ}C$		2.1	
Continuous Drain Current (Note 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-4.4	Α
		T <sub>A</sub> = 85°C		-3.2	
Power Dissipation (Note 3)	Power Dissipation (Note 3) T <sub>A</sub> = 25°C				W
Pulsed Drain Current	t <sub>p</sub> = .	10 μs	I <sub>DM</sub>	-25	Α
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C		
Operating Case Temperature (Note 3)				-55 to 125	°C
Source Current (Body Diode) <sup>2</sup>			I <sub>S</sub>	-2.8	Α
Lead Temperature for Soldering Purposes (1/8" from case	for 10 s)		$T_L$	260	°C

# THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	299	°C/W
Junction-to-Ambient - t < 10 s (Note 3)	$R_{\theta JA}$	81.4	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	85.5	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\theta JA}$	58.7	°C/W
Junction-to-Case - t < 10 s (Note 3)	Ψιс	26	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces).
- Surface-mounted on FR4 board using 0.5 in sq pad size, 1 oz. Cu.
   Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

# P-Channel MOSFET Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-12.0			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = -250 \mu A$ , ref to $25^{\circ}C$			-10.1		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C			-1.0	μΑ
		$V_{DS} = -12 V$	T <sub>J</sub> = 125°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±8 V				±200	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	I <sub>D</sub> = -250 μA	-0.45	-0.67	-1.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.68		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$			32	40	mΩ
		V <sub>GS</sub> = -2.5 \	V, I <sub>D</sub> = -3.0 A		44	50	
Forward Transconductance	9FS	V <sub>DS</sub> = −16 \	/, I <sub>D</sub> = -3.0 A		5.9		S

4. Pulsed Condition: Pulse Width = 300  $\mu sec$ , Duty Cycle  $\leq$  2%

# P-Channel MOSFET Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Unit
CHARGES, CAPACITANCES AND GAT	E RESISTANCE			•		•	
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$			1329		pF
Output Capacitance	C <sub>OSS</sub>	$V_{DS} =$	–12 V		200		
Reverse Transfer Capacitance	C <sub>RSS</sub>				116		
Total Gate Charge	Q <sub>G(tot)</sub>	V <sub>GS</sub> = -4.5 V,	V <sub>DS</sub> = -12 V,		13		nC
Threshold Gate Charge	Q <sub>G(th)</sub>	I <sub>D</sub> = -	-3.0 A		1.1		
Gate-to-Source Charge	$Q_GS$				1.7		1
Gate-to-Drain Charge	$Q_{GD}$				2.5		
SWITCHING CHARACTERISTICS				•		•	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -12 \text{ V},$ $I_{D} = -3.0 \text{ A}, R_{G} = 3.0$			8		ns
Rise Time	t <sub>r</sub>				17.5		
Turn-Off Delay Time	t <sub>d(off)</sub>				80		
Fall Time	t <sub>f</sub>				56.5		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Recovery Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C		-0.66	-1.2	V
		$I_S = -1.0 \text{ A}$ $T_J = 125^{\circ}\text{C}$		-0.54			
Reverse Recovery Time	t <sub>rr</sub>	$V_{GS} = 0 \text{ V},$ $dISD/dt = 100 \text{ A}/\mu\text{s},$ $I_{S} = -1.0 \text{ A}$			70.8		ns
Charge Time	t <sub>a</sub>				14.3		
Discharge Time	t <sub>b</sub>				56.4		
Reverse Recovery Charge	Q <sub>RR</sub>				44		nC

# $\textbf{Single-PNP Transistor Maximum Ratings} \; (T_J = 25^{\circ}C \; \text{unless otherwise stated})$

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	$V_{CEO}$	-20	V
Collector-Base Voltage	$V_{CBO}$	-20	V
Emitter-Base Voltage	$V_{EBO}$	-7.0	V
Collector Current, Continuous	I <sub>C</sub>	-2.0	Α
Collector Current, Peak	I <sub>C</sub>	-4.0	Α
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Power Dissipation, T <sub>A</sub> = 25°C (Note 5)	$P_{D}$	1.58	W
Thermal Resistance (Note 5)	$R_{\theta JA}$	61.5	°C/W
Power Dissipation, T <sub>A</sub> = 25°C (Note 6)	$P_{D}$	0.43	W
Thermal Resistance (Note 6)	$R_{\theta JA}$	293	°C/W

<sup>5.</sup> Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 sq in [1 oz] including traces)
6. Surface-mounted on FR4 board using 50 sq mm pad size, 1 oz. Cu.

Single-PNP Transistor Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
OFF CHARACTERISTICS						
Collector-Emitter Breakdown Voltage	Vbr <sub>CEO</sub>	$I_C = -10 \text{ mA}, I_B = 0$	-20			V
Collector-Base Breakdown Voltage	Vbr <sub>CBO</sub>	$I_{C} = -0.1 \text{ mA}, I_{E} = 0$	-20			V
Emitter-Base Breakdown Voltage	Vbr <sub>EBO</sub>	$I_E = -0.1 \text{ mA}, I_C = 0$	-7.0			V
Collector-Emitter Cutoff Current	I <sub>CES</sub>	V <sub>CES</sub> = −15 V			-0.1	μΑ
ON CHARACTERISTICS						
DC Current Gain (Note 7)	h <sub>FE</sub>	$I_C = -1.0 \text{ A}, V_{CE} = -2.0 \text{ V}$	180			_
DC Current Gain (Note 7)	h <sub>FE</sub>	$I_C = -2.0 \text{ A}, V_{CE} = -2.0 \text{ V}$	150			-
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_C = -1.0 \text{ A}, I_B = -0.01 \text{ A}$		-0.10	-0.12	V
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_C = -1.0 \text{ A}, I_B = -0.1 \text{ A}$		-0.065	-0.09	V
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_C = -2.0 \text{ A}, I_B = -0.2 \text{ A}$		-0.13	-0.18	V
Base-Emitter Saturation Voltage (Note 7)	V <sub>BE(sat)</sub>	I <sub>C</sub> = -1.0 A, I <sub>B</sub> = -0.01 A			-0.9	V
Base-Emitter Turn-On Voltage (Note 7)	V <sub>BE(on)</sub>	I <sub>C</sub> = -1.0 A, I <sub>B</sub> = -2.0 A			-0.9	V
Cutoff Frequency (Note 8)	f <sub>T</sub>	$I_C = -100 \text{ mA}, V_{CE} = -5.0 \text{ V}$ f = 100 MHz	100			MHz
Input Capacitance (Note 8)	C <sub>ibo</sub>	V <sub>EB</sub> = -0.5 V, f = 1.0 MHz			330	pF
Output Capacitance (Note 8)	C <sub>obo</sub>	V <sub>CB</sub> = -3.0 V, f = 1.0 MHz			100	pF

<sup>7.</sup> Pulsed Condition: Pulse Width = 300  $\mu$ sec, Duty Cycle  $\leq$  2% 8. Guaranteed by design but not tested.

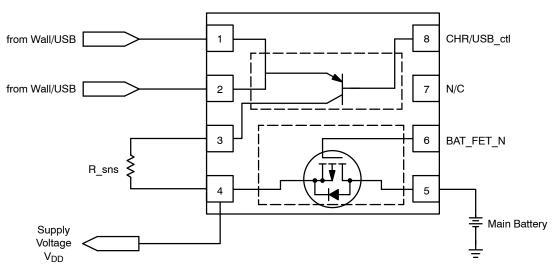


Figure 2. Typical Application Circuit

# **TYPICAL CHARACTERISTICS - MOSFET**

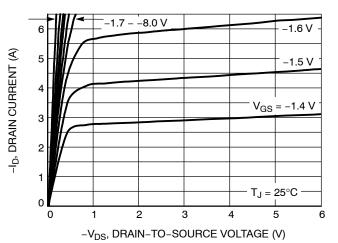


Figure 3. On-Region Characteristics

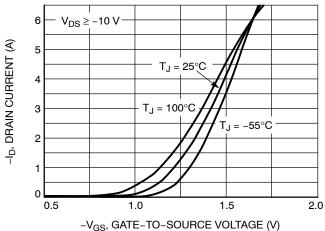


Figure 4. Transfer Characteristics

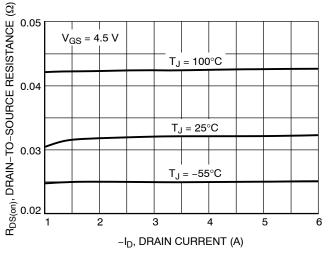


Figure 5. On-Resistance vs. Drain Current

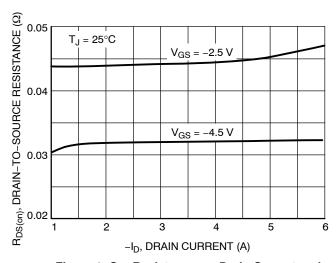


Figure 6. On-Resistance vs. Drain Current and Gate Voltage

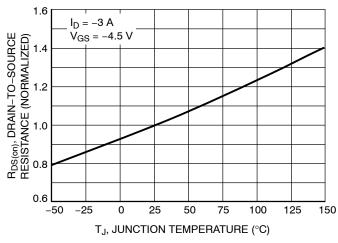


Figure 7. On–Resistance Variation with Temperature

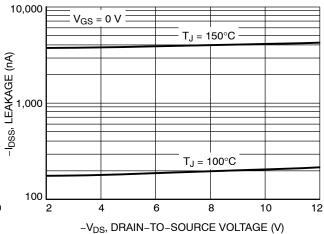
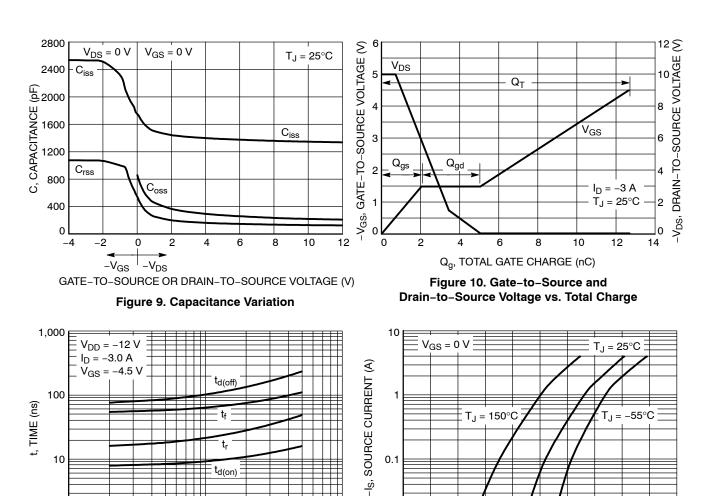


Figure 8. Drain-to-Source Leakage Current vs. Voltage

# TYPICAL CHARACTERISTICS - MOSFET

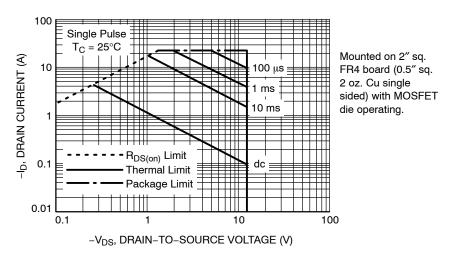


 $\label{eq:RGG} \text{RG, GATE RESISTANCE }(\Omega)$  Figure 11. Resistive Switching Time Variation vs. Gate Resistance

-V<sub>SD</sub>, SOURCE-TO-DRAIN VOLTAGE (V)

Figure 12. Diode Forward Voltage vs. Current

1.0



0.01

0.2

100

Figure 13. Maximum Rated Forward Biased Safe Operating Area

# **TYPICAL CHARACTERISTICS - MOSFET**

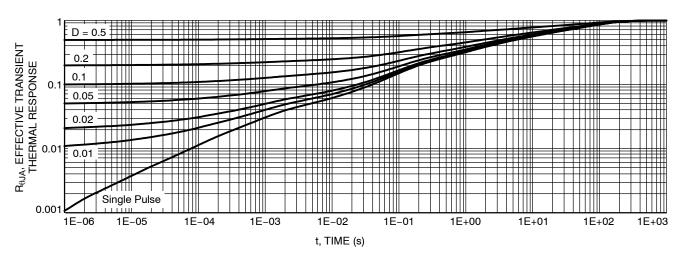


Figure 14. FET Thermal Response

# **TYPICAL CHARACTERISTICS - BJT**

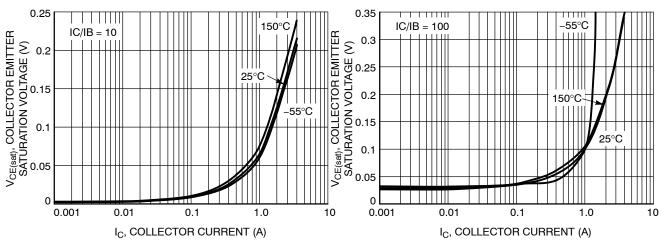


Figure 15. Collector Emitter Saturation Voltage vs. Collector Current

Figure 16. Collector Emitter Saturation Voltage vs. Collector Current

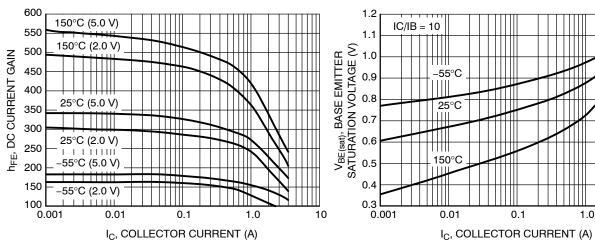


Figure 17. DC Current Gain vs. Collector Current

Figure 18. Base Emitter Saturation Voltage vs. Collector Current

10

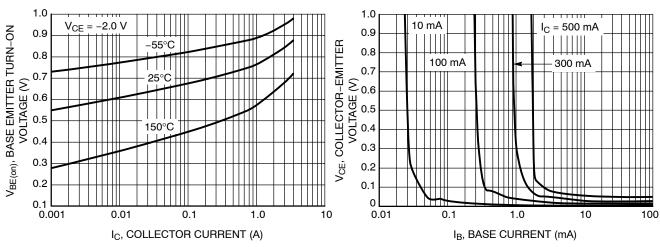


Figure 19. Base Emitter Turn-On Voltage vs. Collector Current

Figure 20. Saturation Region

# **TYPICAL CHARACTERISTICS - BJT**

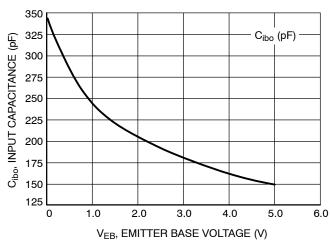


Figure 21. Input Capacitance

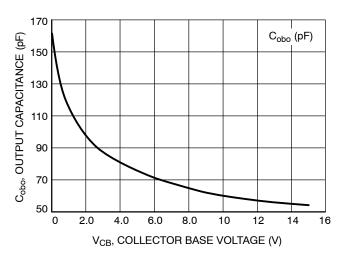
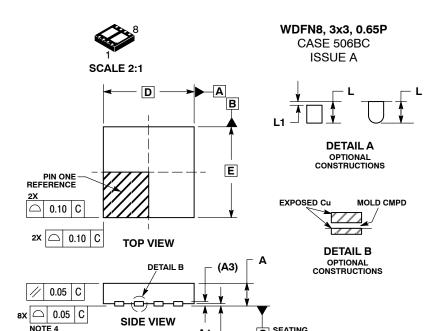


Figure 22. Output Capacitance





Α1

SEATING PLANE

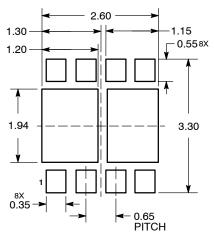
**DATE 28 MAY 2008** 

### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIM	ETERS		
DIM	MIN	MAX		
Α	0.70	0.80		
A1	0.00	0.05		
А3	0.20	REF		
b	0.25	0.35		
D	3.00	BSC		
D2	1.00	1.20		
D3	0.95	1.15		
E	3.00 BSC			
E2	1.70 1.90			
е	0.65	BSC		
G2	0.15 BSC			
G3	0.20 BSC			
K	0.20			
Ĺ	0.25	0.45		
L1		0.15		

# **SOLDERING FOOTPRINT\***



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

G2 →	←
	<b>←</b> G3
⊕ 0.10 C A B	⊕ 0.10   C   A   B
D2— <del>&lt; &gt;</del>	<b>← →</b> D3
<u> </u>	4
(_) [	
8X L -	<u> </u>
DETAIL A	
	-
↓	
<del>*                                     </del>	
<u> </u>	⊕ 0.10 C A B
8x K <sup>_</sup> 8	≥ 5 × 8x b
	0.10 C A B
<u>e/2</u> →	◆ 0.05 C NOTE 3
ВОТТОМ	// VIEW

# **GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code = Assembly Location Α

Υ = Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

98AON23220D

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**DESCRIPTION:** 

WDFN8, 3X3, 0.65P, DUAL FLAG

PAGE 1 OF 1

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